

HAC RF TEST REPORT

No. I15Z41840-SEM03

For

TCL Communication Ltd

HSUPA/HSDPA/UMTS Quad-band/GSM Quad-band mobile phone

Model Name: 4028S

With

Hardware Version: PIO

Software Version: v6DB2

FCC ID: 2ACCJH027

Results Summary: M Category = M3

Issued Date: 2015-07-30



Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of CTTL.

Test Laboratory:

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REPORT HISTORY

| Report Number | Revision | Issue Date | Description |
|-----------------|----------|------------|---------------------------------|
| I15Z41840-SEM03 | Rev.0 | 2015-07-30 | Initial creation of test report |



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1 Test Laboratory

1.1 Testing Location

| Company Name: | CTTL(Shouxiang) |
|---------------|--|
| Address: | No. 51 Shouxiang Science Building, Xueyuan Road, Haidian District, |
| | Beijing, P. R. China100191 |

1.2 Testing Environment

Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards

1.3 Project Data

| Project Leader: | Qi Dianyuan |
|---------------------|---------------|
| Test Engineer: | Lin Hao |
| Testing Start Date: | July 27, 2015 |
| Testing End Date: | July 27, 2015 |

1.4 Signature

Lin Hao

(Prepared this test report)

Qi Dianyuan

(Reviewed this test report)

Xiao Li

Deputy Director of the laboratory

(Approved this test report)



2 Client Information

2.1 Applicant Information

| Company Name: | TCL Communication Ltd | | |
|----------------|---|--|--|
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| Address /Post. | Pudong Area Shanghai, P.R. China. 201203 | | |
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2.2 Manufacturer Information

| Company Name: | TCL Communication Ltd | | |
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| Fax: | 0086-21-61460602 | | |



3 Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1 About EUT

| Description: | HSUPA/HSDPA/UMTS Quad-band/GSM Quad-band mobile phone |
|--------------------|---|
| Model name: | 4028S |
| Operating mode(s): | GSM 850/900/1800/1900, WCDMA 850/1700/1900/2100, BT, WiFi |

3.2 Internal Identification of EUT used during the test

| EUT ID* | IMEI | HW Version | SW Version |
|---------|-----------------|------------|------------|
| EUT1 | 352505070003597 | PIO | v6DB2 |
| EUT2 | 352505070003217 | PIO | v6DB2 |

^{*}EUT ID: is used to identify the test sample in the lab internally.

Note: It is performed to test HAC with the EUT1 and conducted power with the EUT2.

3.3 Internal Identification of AE used during the test

| AE ID* | Description | Model | SN | Manufacturer |
|--------|-------------|--------------|----|--------------|
| AE1 | Battery | CAB60B0000C1 | / | BYD |
| AE2 | Battery | CAB60B0002C1 | / | BYD |
| AE3 | Battery | CAB60B0000CB | / | OCEANSUN |
| AE4 | Battery | CAB1400002C2 | / | SCUD |
| AE5 | Battery | CAB1650001C1 | / | BYD |

^{*}AE ID: is used to identify the test sample in the lab internally.

Note: It is performed for HAC with AE1.

3.4 Air Interfaces / Bands Indicating Operating Modes

| Air-interface | Band(MHz) | Туре | C63.19/tested | Simultaneous Transmissions | ОТТ | Power Reduction |
|---------------|-----------|--------|---------------|-------------------------------|------|--------------------|
| GSM | 850 | VO | Voc | | | NΙΔ |
| GSIVI | 1900 | VO Yes | | DT W/F | NI A | NA |
| GPRS/EDGE | 850 | DT | NA | BT, WiFi | NA | No |
| GPK3/EDGE | 1900 NA | | | | INO | |
| | 850 | | | | | |
| WCDMA | 1700 | VO | Yes | BT, WiFi | NA | NA |
| (UMTS) | 1900 | | | DI, WIFI | | INA |
| | HSPA | DT | NA | | | |
| ВТ | 2450 | DT | NA | GSM, WCDMA | NA | NA |
| WLAN | 2450 | DT | NA | GSM, WCDMA | NA | NA |

VO: Voice CMRS/PSTN Service Only

V/D: Voice CMRS/PSTN and Data Service

DT: Digital Transport

^{*} HAC Rating was not based on concurrent voice and data modes, Non current mode was found to represent worst case rating for both M and T rating



4 CONDUCTED OUTPUT POWER MEASUREMENT

4.1 Summary

During the process of testing, the EUT was controlled via Agilent Digital Radio Communication tester (E5515C) to ensure the maximum power transmission and proper modulation. This result contains conducted output power for the EUT. In all cases, the measured output power should be greater and within 5% than EMI measurement.

4.2 Conducted Power

| GSM | Conducted Power (dBm) | | | | | |
|------------------|--------------------------|------------------------|--------------------------|--|--|--|
| 850MHz | Channel 251(848.8MHz) | Channel 190(836.6MHz) | Channel 128(824.2MHz) | | | |
| | 32.05 | 32.01 | 32.01 | | | |
| GSM | | Conducted Power (dBm) | | | | |
| 1900MHz | Channel 810(1909.8MHz) | Channel 661(1880MHz) | Channel 512(1850.2MHz) | | | |
| ISOUNIEZ | 28.93 | 28.90 | 28.85 | | | |
| MCDMA | Conducted Power (dBm) | | | | | |
| WCDMA | Channel 4233(846.6MHz) | Channel 4182(836.4MHz) | Channel 4132(826.4MHz) | | | |
| 850MHz | 22.63 | 22.17 | 22.29 | | | |
| WCDMA | Conducted Power (dBm) | | | | | |
| 1900MHz | Channel 9538(1907.6MHz) | Channel 9400(1880MHz) | Channel 9262(1852.4MHz) | | | |
| 1900WHZ | 22.44 | 22.48 | 22.27 | | | |
| WCDMA | | Conducted Power (dBm) | | | | |
| WCDMA 1700MHz | Channel 1513 (1752.6MHz) | Channel1412(1732.4MHz) | Channel 1312 (1712.4MHz) | | | |
| 17 OUNITZ | 22.37 | 21.88 | 22.33 | | | |

5. Reference Documents

5.1 Reference Documents for testing

The following document listed in this section is referred for testing.

| Reference | Title | Version |
|-------------------|---|---------|
| ANSI C63.19-2011 | American National Standard for Methods of Measurement | 2011 |
| | of Compatibility between Wireless Communication Devices | Edition |
| | and Hearing Aids | |
| FCC 47 CFR §20.19 | Hearing Aid Compatible Mobile Headsets | / |
| KDB 285076 D01 | Equipment Authorization Guidance for Hearing Aid | v04 |
| | Compatibility | |



6 OPERATIONAL CONDITIONS DURING TEST

6.1 HAC MEASUREMENT SET-UP

These measurements are performed using the DASY5 NEO automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and remote control, is used to drive the robot motors. The PC consists of the HP Intel Core2 1.86 GHz computer with Windows XP system and HAC Measurement Software DASY5 NEO, A/D interface card, monitor, mouse, and keyboard. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

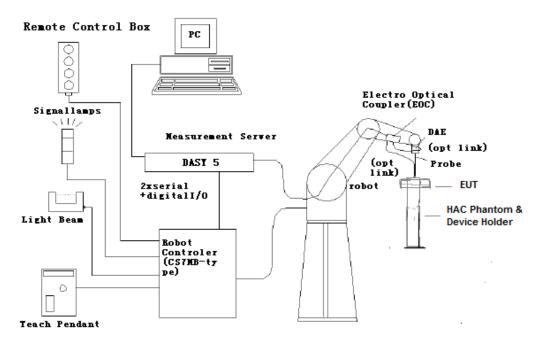


Fig. 1 HAC Test Measurement Set-up

The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.



6.2 Probe Specification

E-Field Probe Description

Construction One dipole parallel, two dipoles normal to probe axis

Built-in shielding against static charges

PEEK enclosure material

Calibration In air from 100 MHz to 3.0 GHz (absolute accuracy ±6.0%,

k=2)

Frequency 40 MHz to > 6 GHz (can be extended to < 20 MHz)

Linearity: ± 0.2 dB (100 MHz to 3 GHz)

Directivity ± 0.2 dB in air (rotation around probe axis)

± 0.4 dB in air (rotation normal to probe axis)

Dynamic Range 2 V/m to > 1000 V/m; Linearity: ± 0.2 dB

Dimensions Overall length: 330 mm (Tip: 16 mm)

Tip diameter: 8 mm (Body: 12 mm)

Distance from probe tip to dipole centers: 2.5 mm

Application General near-field measurements up to 6 GHz

Field component measurements

Fast automatic scanning in phantoms



[ER3DV6]



6.3 Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions: $370 \times 370 \times 370 \text{ mm}$).

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field $<\pm 0.5$ dB.



Fig. 2 HAC Phantom & Device Holder

6.4 Robotic System Specifications

Specifications

Positioner: Stäubli Unimation Corp. Robot Model: RX160L

Repeatability: ±0.02 mm

No. of Axis: 6

Data Acquisition Electronic (DAE) System

Cell Controller

Processor: Intel Core2 Clock Speed: 1.86 GHz

Operating System: Windows XP

Data Converter

Features: Signal Amplifier, multiplexer, A/D converter, and control logic

Software: DASY5 software

Connecting Lines: Optical downlink for data and status info.

Optical uplink for commands and clock



7 EUT ARRANGEMENT

7.1 WD RF Emission Measurements Reference and Plane

Figure 4 illustrates the references and reference plane that shall be used in the WD emissions measurement.

- The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids.
- The grid is centered on the audio frequency output transducer of the WD (speaker or T-coil).
- The grid is located by reference to a reference plane. This reference plane is the planar area that contains the highest point in the area of the WD that normally rests against the user's ear
- The measurement plane is located parallel to the reference plane and 15 mm from it, out from the phone. The grid is located in the measurement plane.

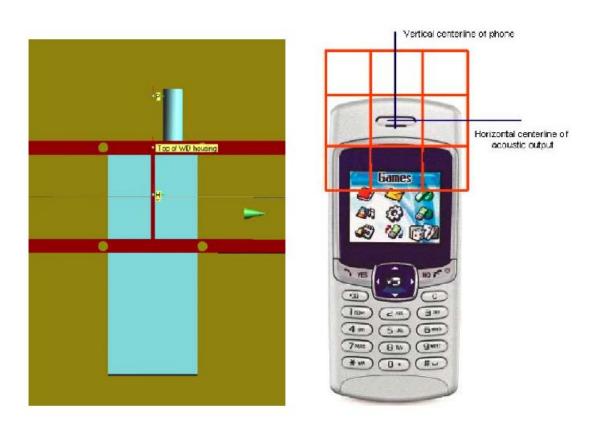


Fig. 3 WD reference and plane for RF emission measurements



8 SYSTEM VALIDATION

8.1 Validation Procedure

Place a dipole antenna meeting the requirements given in ANSI C63.19 in the position normally occupied by the WD. The dipole antenna serves as a known source for an electrical output. Position the E-field probes so that:

- · The probes and their cables are parallel to the coaxial feed of the dipole antenna
- The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions
- The center point of the probe element(s) are 15 mm from the closest surface of the dipole elements.

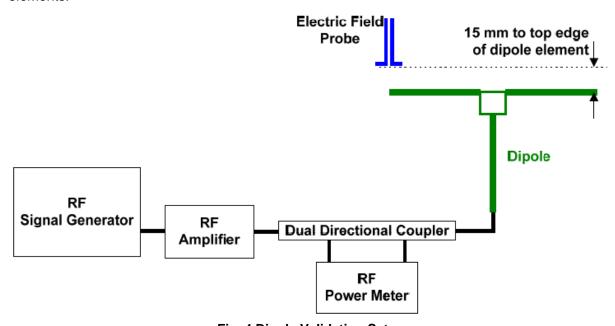


Fig. 4 Dipole Validation Setup

8.2 Validation Result

| | E-Field Scan | | | | | | | | |
|------|--|------|--------------|--------------|------|-----|--|--|--|
| Mode | Mode Frequency Input Power Measured ¹ Target ² Deviation ³ Limit ⁴ | | | | | | | | |
| | (MHz) | (mW) | Value(dBV/m) | Value(dBV/m) | (%) | (%) | | | |
| CW | 835 | 100 | 40.79 | 40.7 | 1.04 | ±25 | | | |
| CW | 1880 | 100 | 39.11 | 39.04 | 0.81 | ±25 | | | |

Notes:

- 1. Please refer to the attachment for detailed measurement data and plot.
- 2. Target value is provided by SPEAD in the calibration certificate of specific dipoles.
- 3. Deviation (%) = 100 * (Measured value minus Target value) divided by Target value.
- 4. ANSI C63.19 requires values within \pm 25% are acceptable, of which 12% is deviation and 13% is measurement uncertainty. Values independently validated for the dipole actually used in the measurements should be used, when available.



9 Evaluation of MIF

9.1 Introduction

The MIF (Modulation Interference Factor) is used to classify E-field emission to determine Hearing Aid Compatibility (HAC). It scales the power-averaged signal to the RF audio interference level and is characteristic to a modulation scheme. The HAC standard preferred "indirect" measurement method is based on average field measurement with separate scaling by the MIF. With an Audio Interference Analyzer (AIA) designed by SPEAG specifically for the MIF measurement, these values have been verified by practical measurements on an RF signal modulated with each of the waveforms. The resulting deviations from the simulated values are within the requirements of the HAC standard.

The AIA (Audio Interference Analyzer) is an USB powered electronic sensor to evaluate signals in the frequency range 698 MHz - 6 GHz. It contains RMS detector and audio frequency circuits for sampling of the RF envelope.

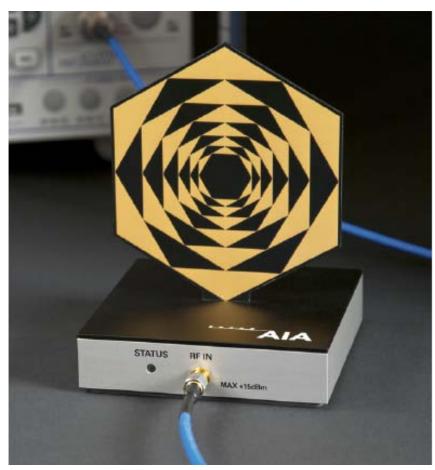


Fig. 5 AIA Front View



9.2 MIF measurement with the AIA

The MIF is measured with the AIA as follows:

- 1. Connect the AIA via USB to the DASY5 PC and verify the configuration settings.
- 2. Couple the RF signal to be evaluated to an AIA via cable or antenna.
- 3. Generate a MIF measurement job for the unknown signal and select the measurement port and timing settings.
- 4. Document the results via the post processor in a report.

9.3 Test equipment for the MIF measurement

| No. | Name | Туре | Serial Number | Manufacturer |
|-----|------------------|---------------|---------------|--------------|
| 01 | Signal Generator | E4438C | MY49071430 | Agilent |
| 02 | AIA | SE UMS 170 CB | 1029 | SPEAG |
| 03 | BTS | E5515C | MY50263375 | Agilent |

9.4 Test signal validation

The signal generator (E4438C) is used to generate a 1GHz signal with different modulation in the below table based on the ANSI C63.19-2011. The measured MIF with AIA are compared with the target values given in ANSI C63.19-2011 table D.3, D.4 and D5.

| Pulse modulation | Target MIF | Measured MIF | Deviation |
|--|------------|--------------|-----------|
| 0.5ms pulse, 1000Hz repetition rate | -0.9 dB | -0.9 dB | 0 dB |
| 1ms pulse, 100Hz repetition rate | +3.9 dB | +3.7 dB | 0.2 dB |
| 0.1ms pulse, 100Hz repetition rate | +10.1 dB | +10.0 dB | 0.1 dB |
| 10ms pulse, 10Hz repetition rate | +1.6 dB | +1.7 dB | 0.1 dB |
| Sine-wave modulation | Target MIF | Measured MIF | Deviation |
| 1 kHz, 80% AM | -1.2 dB | -1.3 dB | 0.1 dB |
| 1 kHz, 10% AM | -9.1 dB | -9.0 dB | 0.1 dB |
| 1 kHz, 1% AM | -19.1 dB | -18.9 dB | 0.2 dB |
| 100 Hz, 10% AM | -16.1 dB | -16.0 dB | 0.1 dB |
| 10 kHz, 10% AM | -21.5 dB | -21.6 dB | 0.1 dB |
| Transmission protocol | Target MIF | Measured MIF | Deviation |
| GSM; full-rate version 2; speech codec/handset low | +3.5 dB | +3.47 dB | 0.03 dB |
| WCDMA; speech; speech codec low; AMR 12.2 kb/s | -20.0 dB | -19.8 dB | 0.2 dB |
| CDMA; speech; SO3; RC3; full frame rate; 8kEVRC | -19.0 dB | -19.1 dB | 0.1 dB |
| CDMA; speech; SO3; RC1; 1/8 th frame rate; 8kEVRC | +3.3 dB | +3.44 dB | 0.14 dB |



9.5 DUT MIF results

| Typical MIF levels in ANSI C63.19-2011 | | | | | |
|--|--------------------------------|--|--|--|--|
| Transmission protocol | Modulation interference factor | | | | |
| GSM; full-rate version 2; speech codec/handset low | +3.5 dB | | | | |
| WCDMA; speech; speech codec low; AMR 12.2 kb/s | -20.0 dB | | | | |

| Measured MIF levels | | | | | | | |
|---------------------|---------|--------------------------------|--|--|--|--|--|
| Band | Channel | Modulation interference factor | | | | | |
| | 251 | +3.48 dB | | | | | |
| GSM 850 | 190 | +3.49 dB | | | | | |
| | 128 | +3.46 dB | | | | | |
| | 810 | +3.47 dB | | | | | |
| GSM 1900 | 661 | +3.49 dB | | | | | |
| | 512 | +3.45 dB | | | | | |
| | 4233 | -19.73 dB | | | | | |
| WCDMA 850 | 4182 | -19.73 dB | | | | | |
| | 4132 | -19.77 dB | | | | | |
| | 9538 | -19.65 dB | | | | | |
| WCDMA 1900 | 9400 | -19.62 dB | | | | | |
| | 9262 | -19.57 dB | | | | | |
| | 1513 | -19.59 dB | | | | | |
| WCDMA 1700 | 1413 | -19.64 dB | | | | | |
| | 1312 | -19.58 dB | | | | | |



10 Evaluation for low-power exemption

10.1 Product testing threshold

There are two methods for exempting an RF air interface technology from testing. The first method requires evaluation of the MIF for the worst-case operating mode. An RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is \leq 17 dBm for any of its operating modes. The second method does not require determination of the MIF. The RF emissions testing exemption shall be applied to an RF air interface technology in a device whose peak antenna input power, averaged over intervals \leq 50 μ s20, is \leq 23 dBm. An RF air interface technology that is exempted from testing by either method shall be rated as M4. The first method is used to be exempt from testing for the RF air interface technology in this report.

10.2 Conducted power

| Band | Average power (dBm) | MIF (dB) | Sum (dBm) |
|------------|---------------------|----------|-----------|
| GSM 850 | 32.05 | +3.48 | 35.53 |
| GSM 1900 | 28.93 | +3.47 | 32.40 |
| WCDMA 850 | 22.63 | -19.73 | 2.90 |
| WCDMA 1900 | 22.48 | -19.62 | 2.86 |
| WCDMA 1700 | 22.37 | -19.59 | 2.78 |

10.3 Conclusion

According to the above table, the sums of average power and MIF for UMTS are less than 17dBm. So it is only measured for GSM bands. The UMTS bands are exempt from testing and rated as M4.



11 RF TEST PROCEDUERES

The evaluation was performed with the following procedure:

- 1) Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
- 2) Position the WD in its intended test position. The gauge block can simplify this positioning.
- 3) Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters (e.g., test mode), as intended for the test.
- 4) The center sub-grid shall centered on the center of the T-Coil mode axial measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane. If the field alignment method is used, align the probe for maximum field reception.
- 5) Record the reading.
- 6) Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading at each measurement point. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
- 7) Identify the five contiguous sub-grids around the center sub-grid whose maximum reading is the lowest of all available choices. This eliminates the three sub-grids with the maximum readings. Thus, the six areas to be used to determine the WD's highest emissions are identified.
- 8) Identify the maximum field reading within the non-excluded sub-grids identified in Step 7)
- 9) Evaluate the MIF and add to the maximum steady-state rms field-strength reading to obtain the RF audio interference level..
- 10) Compare this RF audio interference level with the categories and record the resulting WD category rating.



12 Measurement Results (E-Field)

| Frequency | | Measured Value | Power Drift | Category | | | | | | |
|-----------|---------|----------------|-------------|-------------------------|--|--|--|--|--|--|
| MHz | Channel | (dBV/m) | (dB) | | | | | | | |
| | GSM 850 | | | | | | | | | |
| 848.8 | 251 | 41.66 | -0.10 | M3 (see Fig B.1) | | | | | | |
| 836.6 | 190 | 41.17 | -0.01 | M3 (see Fig B.2) | | | | | | |
| 824.2 | 128 | 40.19 | 0.03 | M3 (see Fig B.3) | | | | | | |
| | | GSM 19 | 00 | | | | | | | |
| 1909.8 | 810 | 30.41 | 0.03 | M3 (see Fig B.4) | | | | | | |
| 1880 | 661 | 30.50 | 0.02 | M3 (see Fig B.5) | | | | | | |
| 1850.2 | 512 | 30.28 | -0.04 | M3 (see Fig B.6) | | | | | | |

13 ANSI C 63.19-2011 LIMITS

WD RF audio interference level categories in logarithmic units

| Emission categories | < 960 | MHz | | | | |
|---------------------|-------------------|----------|--|--|--|--|
| | E-field emissions | | | | | |
| Category M1 | 50 to 55 | dB (V/m) | | | | |
| Category M2 | 45 to 50 | dB (V/m) | | | | |
| Category M3 | 40 to 45 | dB (V/m) | | | | |
| Category M4 | < 40 | dB (V/m) | | | | |
| Emission categories | > 96 | 0 MHz | | | | |
| | E-field e | missions | | | | |
| Category M1 | 40 to 45 | dB (V/m) | | | | |
| Category M2 | 35 to 40 | dB (V/m) | | | | |
| Category M3 | 30 to 35 | dB (V/m) | | | | |
| Category M4 | < 30 | dB (V/m) | | | | |



14 MEASUREMENT UNCERTAINTY

| No. | Error source | Туре | Uncertainty Value (%) | Prob. Dist. | k | C _i | Standard Uncertainty (%) $u_i^{'}$ (%) E | Degree of freedom V_{eff} or v_i |
|------|--------------------------------|------|--------------------------|----------------|------------|----------------|--|--------------------------------------|
| | surement System | | | l | | l , | | I |
| 1 | Probe Calibration | В | 5. | N | 1 | 1 | 5.1 | ∞ |
| 2 | Axial Isotropy | В | 4.7 | R | $\sqrt{3}$ | 1 | 2.7 | ∞ |
| 3 | Sensor Displacement | В | 16.5 | R | $\sqrt{3}$ | 1 | 9.5 | ∞ |
| 4 | Boundary Effects | В | 2.4 | R | $\sqrt{3}$ | 1 | 1.4 | ∞ |
| 5 | Linearity | В | 4.7 | R | $\sqrt{3}$ | 1 | 2.7 | ∞ |
| 6 | Scaling to Peak Envelope Power | В | 2.0 | R | $\sqrt{3}$ | 1 | 1.2 | ∞ |
| 7 | System Detection Limit | В | 1.0 | R | $\sqrt{3}$ | 1 | 0.6 | ∞ |
| 8 | Readout Electronics | В | 0.3 | N | 1 | 1 | 0.3 | ∞ |
| 9 | Response Time | В | 0.8 | R | $\sqrt{3}$ | 1 | 0.5 | ∞ |
| 10 | Integration Time | В | 2.6 | R | $\sqrt{3}$ | 1 | 1.5 | ∞ |
| 11 | RF Ambient Conditions | В | 3.0 | R | $\sqrt{3}$ | 1 | 1.7 | ∞ |
| 12 | RF Reflections | В | 12.0 | R | $\sqrt{3}$ | 1 | 6.9 | ∞ |
| 13 | Probe Positioner | В | 1.2 | R | $\sqrt{3}$ | 1 | 0.7 | ∞ |
| 14 | Probe Positioning | Α | 4.7 | R | $\sqrt{3}$ | 1 | 2.7 | ∞ |
| 15 | Extra. And Interpolation | В | 1.0 | R | $\sqrt{3}$ | 1 | 0.6 | ∞ |
| Test | Sample Related | | | | • | | | |
| 16 | Device Positioning Vertical | В | 4.7 | R | $\sqrt{3}$ | 1 | 2.7 | ∞ |
| 17 | Device Positioning Lateral | В | 1.0 | R | $\sqrt{3}$ | 1 | 0.6 | ∞ |
| 18 | Device Holder and Phantom | В | 2.4 | R | $\sqrt{3}$ | 1 | 1.4 | ∞ |
| 19 | Power Drift | В | 5.0 | R | $\sqrt{3}$ | 1 | 2.9 | ∞ |



| 20 | AIA measurement | В | 12 | R | $\sqrt{3}$ | 1 | 6.9 | ∞ |
|------|--|--------------|-----|---|------------|------|------|---|
| Pha | Phantom and Setup related | | | | | | | |
| 21 | Phantom Thickness | В | 2.4 | R | $\sqrt{3}$ | 1 | 1.4 | 8 |
| Coml | Combined standard uncertainty(%) | | | | | 16.2 | | |
| - | nded uncertainty idence interval of 95 %) | $u_e = 2u_c$ | | N | k= | 2 | 32.4 | |

15 MAIN TEST INSTRUMENTS

Table 1: List of Main Instruments

| No. | Name | Туре | Serial Number | Calibration Date | Valid Period |
|-----|------------------|---------------|---------------|--------------------------|--------------|
| 01 | Signal Generator | E4438C | MY49071430 | February 2, 2015 | One Year |
| 02 | Power meter | NRVD | 102196 | March 03, 2015 | One year |
| 03 | Power sensor | NRV-Z5 | 100596 | March 03, 2015 | One year |
| 04 | Amplifier | 60S1G4 | 0331848 | No Calibration Re | quested |
| 05 | E-Field Probe | ER3DV6 | 2428 | January 23, 2015 | One year |
| 06 | HAC Dipole | CD835V3 | 1023 | September 17, 2014 | One year |
| 07 | HAC Dipole | CD1880V3 | 1018 | September 17, 2014 | One year |
| 80 | BTS | E5515C | MY50263375 | January 30, 2015 | One year |
| 09 | DAE | SPEAG DAE4 | 771 | January 27, 2015 | One year |
| 10 | AIA | SE UMS 170 CB | 1029 | No Calibration Requested | |

16 CONCLUSION

The HAC measurement indicates that the EUT complies with the HAC limits of the ANSI C63.19-2011. The total M-rating is **M3.**

END OF REPORT BODY



ANNEX A TEST LAYOUT



Picture A1: HAC RF System Layout



ANNEX B TEST PLOTS

HAC RF E-Field GSM 850 High

Date: 2015-7-27

Electronics: DAE4 Sn771

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.7°C

Communication System: GSM 850; Frequency: 848.8 MHz; Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2428;ConvF(1, 1, 1)

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device/Hearing Aid

Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 95.22 V/m; Power Drift = -0.10 dB

Applied MIF = 3.48 dB

RF audio interference level = 41.66 dBV/m

Emission category: M3

| Grid 1 M4 | Grid 2 M3 | Grid 3 M3 |
|------------------|------------------|------------------|
| 39.75 dBV/m | 41.21 dBV/m | 41.19 dBV/m |
| Grid 4 M3 | Grid 5 M3 | Grid 6 M3 |
| 40.14 dBV/m | 41.66 dBV/m | 41.64 dBV/m |
| Grid 7 M3 | Grid 8 M3 | Grid 9 M3 |
| 40.41 dBV/m | 41.65 dBV/m | 41.61 dBV/m |

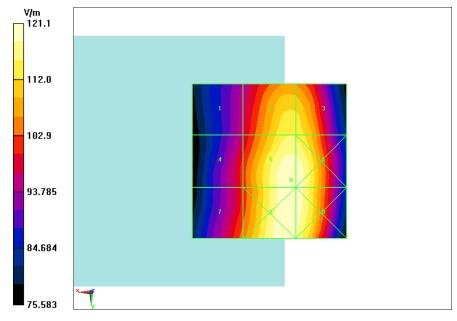


Fig B.1 HAC RF E-Field GSM 850 High



HAC RF E-Field GSM 850 Middle

Date: 2015-7-27

Electronics: DAE4 Sn771

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.7°C

Communication System: GSM 850; Frequency: 836.6 MHz; Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2428;ConvF(1, 1, 1)

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device 2/Hearing Aid

Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 89.41 V/m; Power Drift = -0.01 dB

Applied MIF = 3.49 dB

RF audio interference level = 41.17 dBV/m

Emission category: M3

| Grid 1 M4 | Grid 2 M3 | Grid 3 M3 |
|------------------|-------------|------------------|
| 39.27 dBV/m | 40.69 dBV/m | 40.67 dBV/m |
| Grid 4 M4 | Grid 5 M3 | Grid 6 M3 |
| 39.73 dBV/m | 41.17 dBV/m | 41.12 dBV/m |
| Grid 7 M3 | Grid 8 M3 | Grid 9 M3 |
| 40.01 dBV/m | 41.16 dBV/m | 41.13 dBV/m |

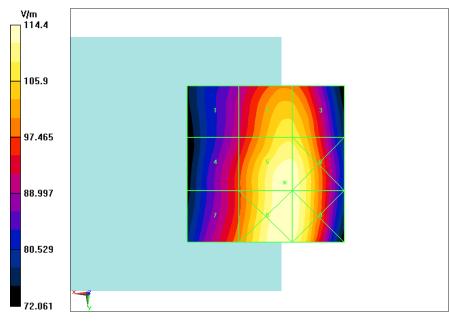


Fig B.2 HAC RF E-Field GSM 850 Middle



HAC RF E-Field GSM 850 Low

Date: 2015-7-27

Electronics: DAE4 Sn771

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.7°C

Communication System: GSM 850; Frequency: 824.2 MHz; Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2428;ConvF(1, 1, 1)

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device 3/Hearing Aid

Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 80.53 V/m; Power Drift = 0.03 dB

Applied MIF = 3.46 dB

RF audio interference level = 40.19 dBV/m

Emission category: M3

| Grid 1 M4 | Grid 2 M4 | Grid 3 M4 |
|------------------|------------------|------------------|
| 38.67 dBV/m | 39.72 dBV/m | 39.69 dBV/m |
| Grid 4 M4 | Grid 5 M3 | Grid 6 M3 |
| 39.08 dBV/m | 40.19 dBV/m | 40.12 dBV/m |
| Grid 7 M4 | Grid 8 M3 | Grid 9 M3 |
| 39.23 dBV/m | 40.22 dBV/m | 40.13 dBV/m |

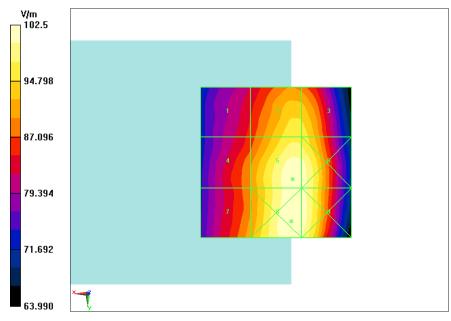


Fig B.3 HAC RF E-Field GSM 850 Low



HAC RF E-Field GSM 1900 High

Date: 2015-7-27

Electronics: DAE4 Sn771

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.7°C

Communication System: DCS 1900; Frequency: 1909.8 MHz; Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2428;ConvF(1, 1, 1)

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device/Hearing Aid

Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 15.86 V/m; Power Drift = 0.03 dB

Applied MIF = 3.47 dB

RF audio interference level = 30.41 dBV/m

Emission category: M3

| Grid 1 M3 | Grid 2 M3 | Grid 3 M3 |
|------------------|------------------|------------------|
| 30.6 dBV/m | 32.12 dBV/m | 32.17 dBV/m |
| Grid 4 M3 | Grid 5 M4 | Grid 6 M4 |
| 30.41 dBV/m | 29.47 dBV/m | 29.59 dBV/m |
| Grid 7 M4 | Grid 8 M4 | Grid 9 M4 |
| 29.69 dBV/m | 28.37 dBV/m | 27.13 dBV/m |

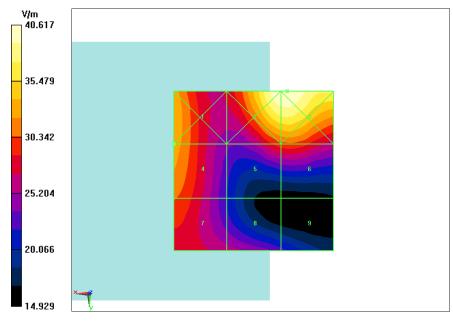


Fig B.4 HAC RF E-Field GSM 1900 High



HAC RF E-Field GSM 1900 Middle

Date: 2015-7-27

Electronics: DAE4 Sn771

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.7°C

Communication System: DCS 1900; Frequency: 1880 MHz; Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2428;ConvF(1, 1, 1)

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device 2/Hearing Aid

Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 17.13 V/m; Power Drift = 0.02 dB

Applied MIF = 3.49 dB

RF audio interference level = 30.50 dBV/m

Emission category: M3

| Grid 1 M3 | Grid 2 M3 | Grid 3 M3 |
|------------------|------------------|------------------|
| 30.58 dBV/m | 32.53 dBV/m | 32.52 dBV/m |
| Grid 4 M3 | Grid 5 M3 | Grid 6 M3 |
| 30.5 dBV/m | 30.17 dBV/m | 30.23 dBV/m |
| Grid 7 M4 | Grid 8 M4 | Grid 9 M4 |
| 29.93 dBV/m | 28.03 dBV/m | 25.57 dBV/m |

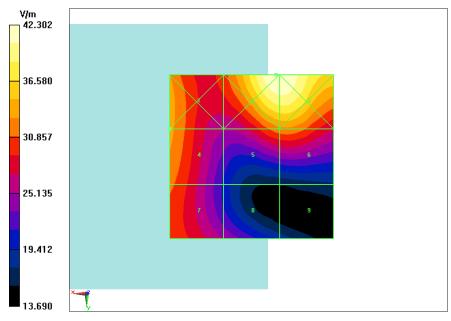


Fig B.5 HAC RF E-Field GSM 1900 Middle



HAC RF E-Field GSM 1900 Low

Date: 2015-7-27

Electronics: DAE4 Sn771

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.7°C

Communication System: DCS 1900; Frequency: 1850.2 MHz; Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2428;ConvF(1, 1, 1)

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device 3/Hearing Aid

Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 18.18 V/m; Power Drift = -0.04 dB

Applied MIF = 3.45 dB

RF audio interference level = 30.28 dBV/m

Emission category: M3

| Grid 1 M3 | Grid 2 M3 | Grid 3 M3 |
|------------------|------------------|------------------|
| 30.33 dBV/m | 32.17 dBV/m | 32.16 dBV/m |
| Grid 4 M3 | Grid 5 M3 | Grid 6 M3 |
| 30.28 dBV/m | 30.25 dBV/m | 30.28 dBV/m |
| Grid 7 M4 | Grid 8 M4 | Grid 9 M4 |
| 29.71 dBV/m | 26.95 dBV/m | 25.26 dBV/m |

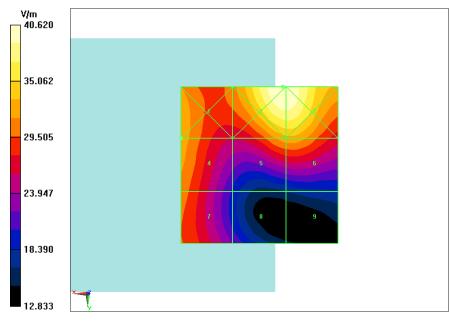


Fig B.6 HAC RF E-Field GSM 1900 Low



ANNEX C SYSTEM VALIDATION RESULT

E SCAN of Dipole 835 MHz

Date: 2015-7-27

Electronics: DAE4 Sn771

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon r = 1$; $\rho = 1000$ kg/m3 Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Probe: ER3DV6 - SN2428;ConvF(1, 1, 1)

E Scan - measurement distance from the probe sensor center to CD835 Dipole = 15mm/Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm,

dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

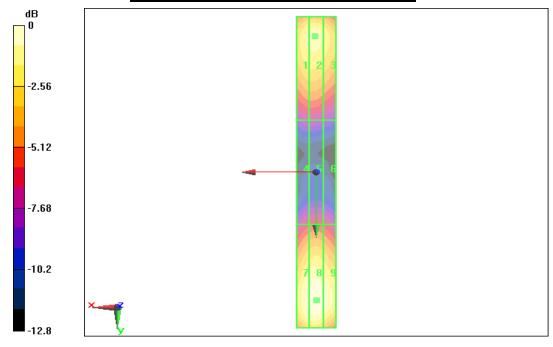
Reference Value = 109.78 V/m; Power Drift = 0.05 dB

Applied MIF = 0.00 dB

RF audio interference level = 40.79 dBV/m

Emission category: M3

| Grid 1 M3 | Grid 2 M3 | Grid 3 M3 |
|------------------|-------------|------------------|
| 40.62 dBV/m | 40.79 dBV/m | 40.70 dBV/m |
| Grid 4 M4 | Grid 5 M4 | Grid 6 M4 |
| 35.80 dBV/m | 36.13 dBV/m | 36.08 dBV/m |
| Grid 7 M3 | Grid 8 M3 | Grid 9 M3 |
| 40.25 dBV/m | 40.52 dBV/m | 40.47 dBV/m |



0 dB = 40.79 dBV/m



E SCAN of Dipole 1880 MHz

Date: 2015-7-27

Electronics: DAE4 Sn771

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: ER3DV6 - SN2428;ConvF(1, 1, 1)

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm,

dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

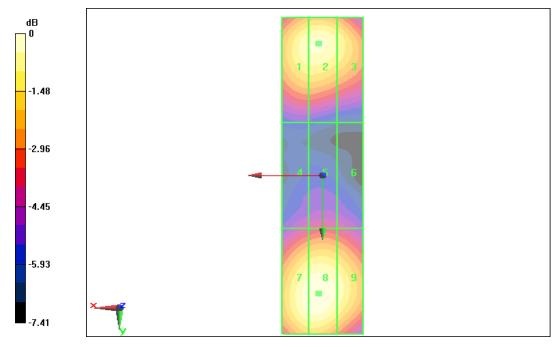
Reference Value = 90.57 V/m; Power Drift = 0.06 dB

Applied MIF = 0.00 dB

RF audio interference level = 39.11 dBV/m

Emission category: M2

| Grid 1 M2 | Grid 2 M2 | Grid 3 M2 |
|------------------|------------------|------------------|
| 38.90 dBV/m | 39.11 dBV/m | 38.99 dBV/m |
| Grid 4 M2 | Grid 5 M2 | Grid 6 M2 |
| 36.51 dBV/m | 36.76 dBV/m | 36.70 dBV/m |
| Grid 7 M2 | Grid 8 M2 | Grid 9 M2 |
| 38.93 dBV/m | 39.03 dB V/m | 38.97 dBV/m |



0 dB = 39.11 dBV/m



ANNEX D PROBE CALIBRATION CERTIFICATE

E_Probe ER3DV6

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client

CTTL (Auden)

Certificate No: ER3-2428_Jan15

CALIBRATION CERTIFICATE

Object

ER3DV6 - SN:2428

Calibration procedure(s)

QA CAL-02.v8, QA CAL-25.v6

Calibration procedure for E-field probes optimized for close near field

evaluations in air

Calibration date:

January 23, 2015

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards | ID | Cal Date (Certificate No.) | Scheduled Calibration |
|----------------------------|-----------------|---------------------------------------|------------------------|
| Power meter E4419B | GB41293874 | 03-Apr-14 (No. 217-01911) Apr-15 | |
| Power sensor E4412A | MY41498087 | 03-Apr-14 (No. 217-01911) | Apr-15 |
| Reference 3 dB Attenuator | SN: S5054 (3c) | 03-Apr-14 (No. 217-01915) | Apr-15 |
| Reference 20 dB Attenuator | SN: S5277 (20x) | 03-Apr-14 (No. 217-01919) | Apr-15 |
| Reference 30 dB Attenuator | SN: S5129 (30b) | 03-Apr-14 (No. 217-01920) | Apr-15 |
| Reference Probe ER3DV6 | SN: 2328 | 08-Oct-14 (No. ER3-2328_Oct14) Oct-15 | |
| DAE4 | SN: 789 | 30-Apr-14 (No. DAE4-789_Apr14) Apr-15 | |
| Secondary Standards | ID | Check Date (in house) | Scheduled Check |
| RF generator HP 8648C | US3642U01700 | 4-Aug-99 (in house check Apr-13) | In house check: Apr-16 |
| Network Analyzer HP 8753E | US37390585 | 18-Oct-01 (in house check Oct-14) | In house check: Oct-15 |

Name Function Signature

Leif Klysner Laboratory Technician Sef Alguman Approved by:

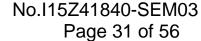
Katja Pokovic Technical Manager

Issued: January 26, 2015

This calibration certificate shall not be reproduced except in full without written approval of the laboratory

Certificate No: ER3-2428_Jan15

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service sulsse d'étalonnage
Servizio svizzero di taratura
Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

NORMx,y,z DCP sensitivity in free space

DCP diode compression point
CF crest factor (1/duty_cycle) of the RF signal

A, B, C, D Polarization φ

modulation dependent linearization parameters

 $\boldsymbol{\phi}$ rotation around probe axis

Polarization 9

3 rotation around an axis that is in the plane normal to probe axis (at measurement center),

i.e., $\vartheta = 0$ is normal to probe axis

Connector Angle

information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
- b) CTIA Test Plan for Hearing Aid Compatibility, April 2010.

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization 9 = 0 for XY sensors and 9 = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

January 23, 2015



ER3DV6 - SN:2428

Probe ER3DV6

SN:2428

Calibrated:

Manufactured: September 11, 2007 January 23, 2015

Calibrated for DASY/EASY Systems (Note: non-compatible with DASY2 system!)

Certificate No: ER3-2428_Jan15

Page 3 of 10



ER3DV6 - SN:2428

January 23, 2015

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2428

Basic Calibration Parameters

| | Sensor X | Sensor Y | Sensor Z | Unc (k=2) |
|-------------------------------|----------|----------|----------|-----------|
| Norm (µV/(V/m) ²) | 1.51 | 1.58 | 1.83 | ± 10.1 % |
| DCP (mV) ^B | 101.6 | 99.5 | 102.3 | |

Modulation Calibration Parameters

| UID | Communication System Name | | A dB | B dB√μV | С | D dB | VR mV | Unc ^E (k=2) |
|---------------|---------------------------|---|---------|------------|------|---------|----------|---------------------------|
| 0 | CW | X | 0.0 | 0.0 | 1.0 | 0.00 | 189.0 | ±3.8 % |
| | | Y | 0.0 | 0.0 | 1.0 | | 207.2 | |
| | | Z | 0.0 | 0.0 | 1.0 | | 199.4 | |
| 10011- CAB | UMTS-FDD (WCDMA) | X | 3.18 | 66.7 | 18.9 | 2.91 | 112.3 | ±0.7 % |
| | | Y | 3.14 | 66.0 | 18.2 | | 123.4 | |
| | | Z | 3.14 | 66.4 | 18.4 | | 116.3 | |
| 10021- DAB | GSM-FDD (TDMA, GMSK) | X | 16.25 | 97.6 | 28.0 | 9.39 | 106.6 | ±1.7 % |
| | | Y | 9.84 | 90.3 | 25.6 | | 112.7 | |
| | | Z | 18.91 | 97.3 | 27.6 | | 121.7 | |
| 10039- CAB | CDMA2000 (1xRTT, RC1) | X | 4.67 | 66.4 | 19.2 | 4.57 | 113.6 | ±0.9 % |
| | | Y | 4.71 | 66.5 | 19.1 | | 125.0 | |
| | | Z | 4.49 | 66.0 | 18.8 | | 115.6 | |
| 10081- CAB | CDMA2000 (1xRTT, RC3) | × | 3.75 | 65.2 | 18.3 | 3.97 | 110.4 | ±0.7 % |
| | | Y | 3.78 | 65.2 | 18.2 | | 122.0 | |
| | | Z | 3.69 | 65.3 | 18.3 | | 113.2 | |

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: ER3-2428_Jan15

B Numerical linearization parameter: uncertainty not required.

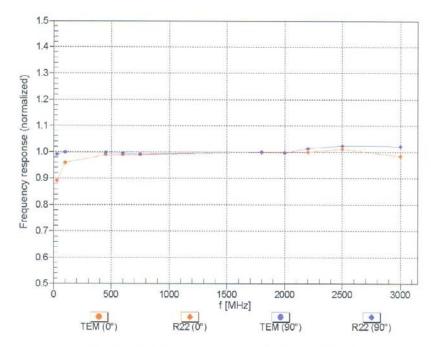
E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



ER3DV6 - SN:2428

January 23, 2015

Frequency Response of E-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)



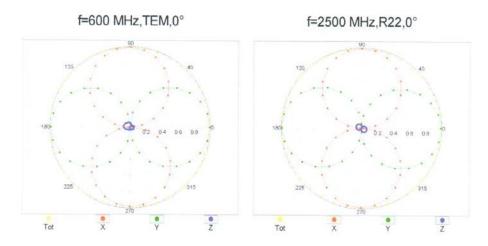
Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

Certificate No: ER3-2428_Jan15

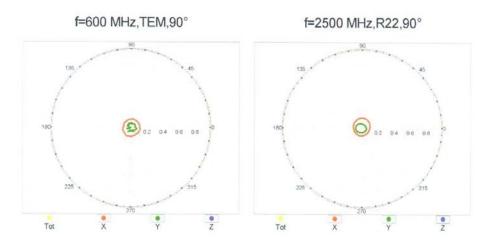


ER3DV6 - SN:2428 January 23, 2015

Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$



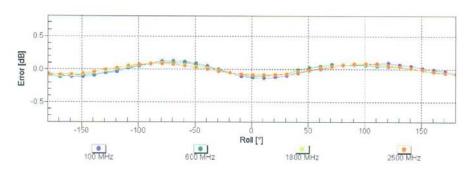
Certificate No: ER3-2428_Jan15 Page 6 of 10



ER3DV6 - SN:2428

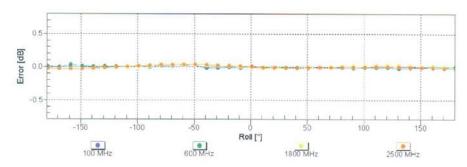
January 23, 2015

Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$



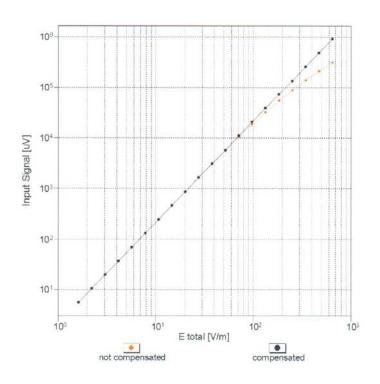
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

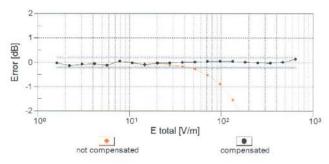


ER3DV6 - SN:2428

January 23, 2015

Dynamic Range f(E-field) (TEM cell , f = 900 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Certificate No: ER3-2428_Jan15

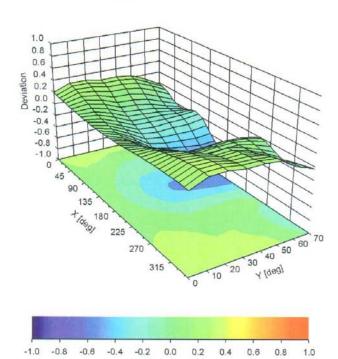
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ER3DV6 - SN:2428

January 23, 2015

Deviation from Isotropy in Air Error (φ, θ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)



ER3DV6 - SN:2428

January 23, 2015

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2428

Other Probe Parameters

| Sensor Arrangement | Rectangular |
|---|-------------|
| Connector Angle (°) | -39.1 |
| Mechanical Surface Detection Mode | enabled |
| Optical Surface Detection Mode | disabled |
| Probe Overall Length | 337 mm |
| Probe Body Diameter | 10 mm |
| Tip Length | 10 mm |
| Tip Diameter | 8 mm |
| Probe Tip to Sensor X Calibration Point | 2.5 mm |
| Probe Tip to Sensor Y Calibration Point | 2.5 mm |
| Probe Tip to Sensor Z Calibration Point | 2.5 mm |
| | |



ANNEX E DIPOLE CALIBRATION CERTIFICATE

Dipole 835 MHz

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Swiss Calibration Service

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Client

CTTL (Auden)

Certificate No: CD835V3-1023 Sep14

Accreditation No.: SCS 108

| | | | The state of the s |
|---|---|--|--|
| Object | CD835V3 - SN: 1 | 1023 | |
| Calibration procedure(s) | QA CAL-20.v6 Calibration proce | edure for dipoles in air | |
| Calibration date: | September 17, 2 | 014 | |
| | eted in the closed laborator | robability are given on the following pages an ny facility: environment temperature $(22 \pm 3)^{\circ}$ C | |
| Primary Standards | ID# | Cal Date (Certificate No.) | Scheduled Calibration |
| | | | |
| Power meter EPM-442A | GB37480704 | 09-Oct-13 (No. 217-01827) | Oct-14 |
| Power sensor HP 8481A | US37292783 | 09-Oct-13 (No. 217-01827) | Oct-14 |
| Power sensor HP 8481A Power sensor HP 8481A | US37292783 MY41092317 | 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) | Oct-14 Oct-14 |
| Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination | US37292783 MY41092317 SN: 5047.2 / 06327 | 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) | Oct-14 Oct-14 Apr-15 |
| Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 | US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 | 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) | Oct-14 Oct-14 Apr-15 Dec-14 |
| Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 | US37292783 MY41092317 SN: 5047.2 / 06327 | 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) | Oct-14 Oct-14 Apr-15 |
| Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 | US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 | 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) | Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 |
| Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B | US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 | 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) 12-Sep-14 (No. DAE4-781_Sep14) | Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 Sep-15 |
| Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A | US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB40202831 SN: MY41498700 | 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 29-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) | Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 Sep-15 Scheduled Check In house check: Oct-15 In house check: Oct-15 |
| Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP E4412A | US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB40202831 SN: MY41498700 SN: MY41502623 | 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 29-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) | Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 Sep-15 Scheduled Check In house check: Oct-15 In house check: Oct-15 In house check: Oct-15 |
| Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Network Analyzer HP 8753E | US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB40202831 SN: MY41498700 SN: MY41502623 US37390585 | 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 29-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) 18-Oct-01 (in house check Oct-13) | Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 Sep-15 Scheduled Check In house check: Oct-15 In house check: Oct-15 In house check: Oct-15 In house check: Oct-15 |
| Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP E4412A Network Analyzer HP 8753E | US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB40202831 SN: MY41498700 SN: MY41502623 | 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 29-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) | Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 Sep-15 Scheduled Check In house check: Oct-15 In house check: Oct-15 In house check: Oct-15 |
| Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Network Analyzer HP 8753E | US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB40202831 SN: MY41498700 SN: MY41502623 US37390585 | 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 29-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) 18-Oct-01 (in house check Oct-13) | Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 Sep-15 Scheduled Check In house check: Oct-15 In house check: Oct-15 In house check: Oct-15 In house check: Oct-15 |
| Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP E4412A Network Analyzer HP 8753E RF generator R&S SMT-06 Calibrated by: | US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB40202831 SN: MY41498700 SN: MY41502623 US37390585 SN: 832283/011 | 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 29-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) 18-Oct-01 (in house check Oct-13) 27-Aug-12 (in house check Oct-13) | Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 Sep-15 Scheduled Check In house check: Oct-15 In house check: Oct-15 In house check: Oct-15 In house check: Oct-14 In house check: Oct-16 |

Certificate No: CD835V3-1023_Sep14

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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C Service suisse d'étalonnage
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Swiss Calibration Service

Accreditation No.: SCS 108

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References

- ANSI-C63.19-2007
 American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [2] ANSI-C63.19-2011 American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna
 (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes.
 In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a
 distance of 10 mm (15 mm for [2]) above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1] and [2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (15 mm for [2]) (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
 antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The
 maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as
 calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the
 feed point.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.



Measurement Conditions

DASY system configuration, as far as not given on page 1.

| DASY Version | DASY5 | V52.8.8 |
|------------------------------------|-----------------|---------|
| Phantom | HAC Test Arch | |
| Distance Dipole Top - Probe Center | 10 mm | |
| Scan resolution | dx, dy = 5 mm | |
| Frequency | 835 MHz ± 1 MHz | |
| Input power drift | < 0.05 dB | |

Maximum Field values at 835 MHz

Averaged maximum above arm

| H-field 10 mm above dipole surface | condition | interpolated maximum |
|------------------------------------|--------------------|--------------------------|
| Maximum measured | 100 mW input power | 0.459 A/m ± 8.2 % (k=2) |
| E-field 10 mm above dipole surface | condition | Interpolated maximum |
| Maximum measured above high end | 100 mW input power | 170.0 V/m = 44.61 dBV/m |
| Maximum measured above low end | 100 mW input power | 158.3 V/m = 43.99 dBV/m |
| Averaged maximum above arm | 100 mW input power | 164.2 V/m ± 12.8 % (k=2) |
| E-field 15 mm above dipole surface | condition | Interpolated maximum |
| Maximum measured above high end | 100 mW input power | 108.3 V/m = 40.69 dBV/m |
| Maximum measured above low end | 100 mW input power | 104.9 V/m = 40.41 dBV/m |
| Averaged maximum above arm | 100 mW input power | 106.6 V/m ± 12.8 % (k=2) |



Appendix (Additional assessments outside the scope of SCS108)

Antenna Parameters

| Frequency | Return Loss | Impedance |
|-----------|-------------|------------------|
| 800 MHz | 16.7 dB | 48.6 Ω - 14.4 jΩ |
| 835 MHz | 24.0 dB | 45.5 Ω + 4.0 jΩ |
| 900 MHz | 16.5 dB | 51.6 Ω + 15.4 jΩ |
| 950 MHz | 20.3 dB | 51.4 Ω - 9.7 jΩ |
| 960 MHz | 16.5 dB | 42.9 Ω - 12.1 jΩ |

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

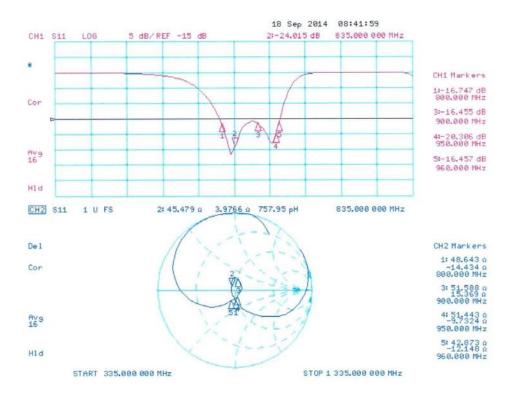
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.



Impedance Measurement Plot





DASY5 H-field Result

Date: 17.09.2014

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1023

Communication System: UID 0 - CW ; Frequency: 835 MHz Medium parameters used: $\sigma=0$ S/m, $\epsilon_r=1$; $\rho=1$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 30.12.2013
- · Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 12.09.2014
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole H-Field measurement @ 835MHz/H-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test (41x361x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

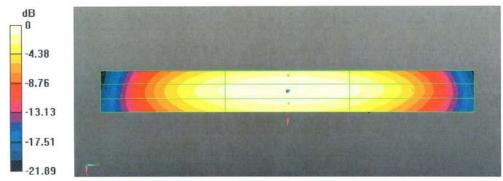
Reference Value = 0.4880 A/m; Power Drift = -0.02 dB

PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.4587 A/m Near-field category: M4 (AWF 0 dB)

PMF scaled H-field

| Grid 1 M4 | Grid 2 M4 | Grid 3 M4 |
|-----------|------------------------|-----------|
| 0.378 A/m | 0.400 A/m | 0.383 A/m |
| | Grid 5 M4 0.459 A/m | |
| | Grid 8 M4 0.410 A/m | |



0 dB = 0.4587 A/m = -6.77 dBA/m



DASY5 E-field Result

Date: 17.09.2014

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1023

Communication System: UID 0 - CW; Frequency: 835 MHz Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 30.12.2013;

• Sensor-Surface: (Fix Surface)

Electronics: DAE4 Sn781; Calibrated: 12.09.2014

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070

DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test (41x361x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 121.3 V/m; Power Drift = -0.02 dB

Applied MIF = 0.00 dB

RF audio interference level = 44.61 dBV/m

Emission category: M3

| Grid 1 M3 | Grid 2 M3 | Grid 3 M3 |
|-------------|-------------|-------------|
| 44.14 dBV/m | 44.61 dBV/m | 44.37 dBV/m |
| Grid 4 M4 | Grid 5 M4 | Grid 6 M4 |
| 38.36 dBV/m | 38.91 dBV/m | 38.82 dBV/m |
| Grid 7 M3 | Grid 8 M3 | Grid 9 M3 |
| 43.52 dBV/m | 43.99 dBV/m | 43.89 dBV/m |



Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid Compatibility Test (41x361x1): Interpolated

grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

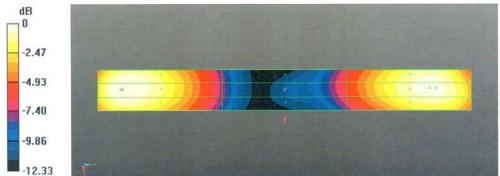
Reference Value = 120.8 V/m; Power Drift = 0.00 dB

Applied MIF = 0.00 dB

RF audio interference level = 40.70 dBV/m

Emission category: M3

| | Grid 2 M3 40.69 dBV/m | |
|-----------------------|--------------------------|--------------------------|
| And the second second | Grid 5 M4 36.03 dBV/m | Grid 6 M4 36 dBV/m |
| | Grid 8 M3 40.41 dBV/m | Grid 9 M3 40.35 dBV/m |



0 dB = 170.0 V/m = 44.61 dBV/m



Dipole 1880 MHz

Calibration Laboratory of Schmid & Partner

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage C Servizio svizzero di taratura S Swiss Calibration Service

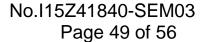
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| CALIBRATION C | Z-111111111111111111111111111111111111 | | |
|---|---|---|---|
| Dbject | CD1880V3 - SN: | 1018 | |
| Calibration procedure(s) | QA CAL-20.v6 Calibration proce | dure for dipoles in air | |
| | | | |
| Calibration date: | September 17, 2 | 014 | |
| | ************************************** | robability are given on the following pages and | |
| | | ry facility: environment temperature (22 ± 3)°C | and humidity < 70%. |
| Calibration Equipment used (M&T | | ry facility: environment temperature (22 ± 3)°C Cal Date (Certificate No.) | and humidity < 70%. Scheduled Calibration |
| Calibration Equipment used (M&T | TE critical for calibration) | | |
| Calibration Equipment used (M&T Primary Standards Power meter EPM-442A | TE critical for calibration) | Cal Date (Certificate No.) | Scheduled Calibration |
| Calibration Equipment used (M&T Primary Standards Power meter EPM-442A Power sensor HP 8481A | TE critical for calibration) ID # GB37480704 | Cal Date (Certificate No.) 09-Oct-13 (No. 217-01827) | Scheduled Calibration Oct-14 |
| Calibration Equipment used (M&T Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A | TE critical for calibration) ID # GB37480704 US37292783 | Cal Date (Certificate No.) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01827) | Scheduled Calibration Oct-14 Oct-14 |
| Calibration Equipment used (M&T Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination | ID # GB37480704 US37292783 MY41092317 | Cal Date (Certificate No.) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) | Scheduled Calibration Oct-14 Oct-14 Oct-14 Apr-15 Dec-14 |
| Calibration Equipment used (M&T Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 | ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 | Cal Date (Certificate No.) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) | Scheduled Calibration Oct-14 Oct-14 Oct-14 Apr-15 |
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| All calibrations have been conduct Calibration Equipment used (M&T Primary Standards Power meter EPM-442A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B | TE critical for calibration) ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 | Cal Date (Certificate No.) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) 12-Sep-14 (No. DAE4-781_Sep14) | Scheduled Calibration Oct-14 Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 Sep-15 |
| Calibration Equipment used (M&T Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B | TE critical for calibration) ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # | Cal Date (Certificate No.) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) | Scheduled Calibration Oct-14 Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 Sep-15 Scheduled Check |
| Calibration Equipment used (M&T Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 | TE critical for calibration) ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB40202831 | Cal Date (Certificate No.) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 29-Oct-13 (in house check Oct-13) | Scheduled Calibration Oct-14 Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 Sep-15 Scheduled Check In house check: Oct-15 |
| Calibration Equipment used (M&T Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A | TE critical for calibration) ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB40202831 SN: MY41498700 | Cal Date (Certificate No.) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 29-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) | Scheduled Calibration Oct-14 Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 Sep-15 Scheduled Check In house check: Oct-15 In house check: Oct-15 |
| Calibration Equipment used (M&T Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP E4412A Network Analyzer HP 8753E | TE critical for calibration) ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB40202831 SN: MY41498700 SN: MY41502623 | Cal Date (Certificate No.) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 29-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) | Scheduled Calibration Oct-14 Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 Sep-15 Scheduled Check In house check: Oct-15 In house check: Oct-15 |
| Calibration Equipment used (M&T Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A | TE critical for calibration) ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB40202831 SN: MY41498700 SN: MY41502623 US37390585 | Cal Date (Certificate No.) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 29-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) 18-Oct-01 (in house check Oct-13) | Scheduled Calibration Oct-14 Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 Sep-15 Scheduled Check In house check: Oct-15 In house check: Oct-15 In house check: Oct-15 In house check: Oct-15 |
| Calibration Equipment used (M&T Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP E4412A Network Analyzer HP 8753E | TE critical for calibration) ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB40202831 SN: MY41498700 SN: MY41502623 US37390585 SN: 832283/011 | Cal Date (Certificate No.) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01827) 09-Oct-13 (No. 217-01828) 03-Apr-14 (No. 217-01921) 30-Dec-13 (No. ER3-2336_Dec13) 30-Dec-13 (No. H3-6065_Dec13) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 29-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) 11-Oct-13 (in house check Oct-13) 18-Oct-01 (in house check Oct-13) 27-Aug-12 (in house check Oct-13) | Scheduled Calibration Oct-14 Oct-14 Oct-14 Apr-15 Dec-14 Dec-14 Sep-15 Scheduled Check In house check: Oct-15 In house check: Oct-15 In house check: Oct-15 In house check: Oct-14 In house check: Oct-14 |

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

References

- [1] ANSI-C63.19-2007 American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [2] ANSI-C63.19-2011 American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna
 (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes.
 In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a
 distance of 10 mm (15 mm for [2]) above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1] and [2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (15 mm for [2]) (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
 antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The
 maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as
 calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the
 feed point.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

| DASY Version | DASY5 | V52.8.8 |
|------------------------------------|------------------|---------|
| Phantom | HAC Test Arch | |
| Distance Dipole Top - Probe Center | 10 mm | |
| Scan resolution | dx, dy = 5 mm | |
| Frequency | 1880 MHz ± 1 MHz | |
| Input power drift | < 0.05 dB | |

Maximum Field values at 1880 MHz

| H-field 10 mm above dipole surface | condition | interpolated maximum |
|------------------------------------|--------------------|-------------------------|
| Maximum measured | 100 mW input power | 0.456 A/m ± 8.2 % (k=2) |
| E-field 10 mm above dipole surface | condition | Interpolated maximum |

| E-field 10 mm above dipole surface | condition | Interpolated maximum |
|------------------------------------|--------------------|--------------------------|
| Maximum measured above high end | 100 mW input power | 143.0 V/m = 43.11 dBV/m |
| Maximum measured above low end | 100 mW input power | 134.6 V/m = 42.58 dBV/m |
| Averaged maximum above arm | 100 mW input power | 138.8 V/m ± 12.8 % (k=2) |

| E-field 15 mm above dipole surface | condition | Interpolated maximum |
|------------------------------------|--------------------|-------------------------|
| Maximum measured above high end | 100 mW input power | 89.5 V/m = 39.04 dBV/m |
| Maximum measured above low end | 100 mW input power | 88.9 V/m = 38.97 dBV/m |
| Averaged maximum above arm | 100 mW input power | 89.2 V/m ± 12.8 % (k=2) |

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Appendix (Additional assessments outside the scope of SCS108)

Antenna Parameters

| Frequency | Return Loss | Impedance |
|-----------|-------------|-----------------|
| 1730 MHz | 27.1 dB | 53.3 Ω + 3.2 jΩ |
| 1880 MHz | 21.6 dB | 49.2 Ω + 8.3 jΩ |
| 1900 MHz | 22.9 dB | 51.6 Ω + 7.1 jΩ |
| 1950 MHz | 32.8 dB | 51.4 Ω + 1.9 jΩ |
| 2000 MHz | 19.2 dB | 41.4 Ω + 5.3 jΩ |

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

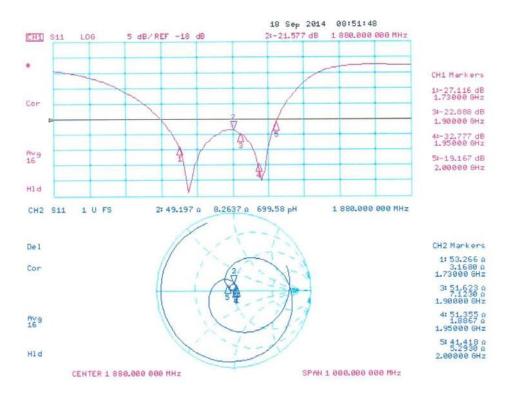
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.



Impedance Measurement Plot





DASY5 H-field Result

Date: 17.09.2014

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1018

Communication System: UID 0 - CW ; Frequency: 1880 MHz Medium parameters used: σ = 0 S/m, ϵ_r = 1; ρ = 1 kg/m 3

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 30.12.2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 12.09.2014
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole H-Field measurement @ 1880MHz/H-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1):

Depois Te Feta theast either to too man between the Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.4820 A/m; Power Drift = 0.02 dB

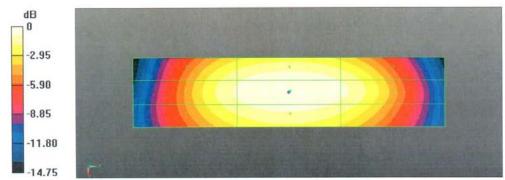
PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.4565 A/m

Near-field category: M2 (AWF 0 dB)

PMF scaled H-field

| Grid 1 M2 | Grid 2 M2 | Grid 3 M2 |
|-----------|-----------|-----------|
| 0.394 A/m | 0.416 A/m | 0.400 A/m |
| Grid 4 M2 | Grid 5 M2 | Grid 6 M2 |
| 0.431 A/m | 0.456 A/m | 0.439 A/m |
| Grid 7 M2 | Grid 8 M2 | Grid 9 M2 |
| 0.394 A/m | 0.422 A/m | 0.405 A/m |



0 dB = 0.4565 A/m = -6.81 dBA/m

Certificate No: CD1880V3-1018_Sep14



DASY5 E-field Result

Date: 17.09.2014

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1018

Communication System: UID 0 - CW; Frequency: 1880 MHz Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 30.12.2013;

• Sensor-Surface: (Fix Surface)

Electronics: DAE4 Sn781; Calibrated: 12.09.2014

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070

DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 141.0 V/m; Power Drift = -0.01 dB Applied MIF = 0.00 dB

RF audio interference level = 43.11 dBV/m

Emission category: M1

| Grid 1 M1 | Grid 2 M1 | Grid 3 M1 |
|-------------|-------------|-------------|
| 42.58 dBV/m | 43.11 dBV/m | 42.82 dBV/m |
| Grid 4 M2 | Grid 5 M2 | Grid 6 M2 |
| 38.25 dBV/m | 38.77 dBV/m | 38.69 dBV/m |
| Grid 7 M1 | Grid 8 M1 | Grid 9 M1 |
| 42.18 dBV/m | 42.58 dBV/m | 42.44 dBV/m |



Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated

grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm

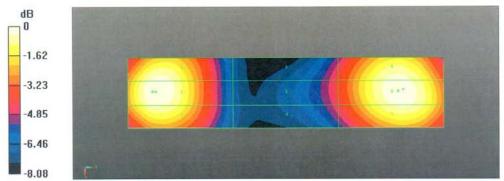
Reference Value = 140.9 V/m; Power Drift = -0.02 dB

Applied MIF = 0.00 dB

RF audio interference level = 39.04 dBV/m

Emission category: M2

| | Grid 2 M2 39.04 dBV/m | Grid 3 M2 38.91 dBV/m |
|-------------------------|--------------------------|--------------------------|
| Service and Contraction | Grid 5 M2 36.65 dBV/m | Grid 6 M2 36.61 dBV/m |
| STATE HOUSE | Grid 8 M2 38.97 dBV/m | Grid 9 M2 38.87 dBV/m |



0 dB = 143.0 V/m = 43.11 dBV/m



The photos of HAC test are presented in the additional document:

Appendix to test report no. I15Z41840-SEM03/04

The photos of HAC test